



**YEA SHIN TECHNOLOGY CO., LTD**

**YS3407**

## P-Channel Enhancement MOSFET

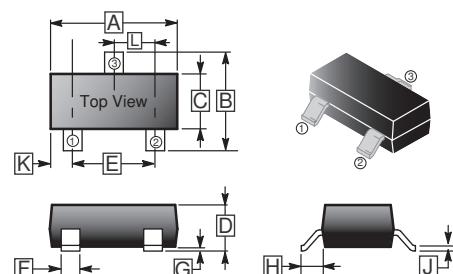
**VDS = -30V, ID = -4.1A**

(Pb) (H)

### DESCRIPTION

The YS3407 provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness. The SOT-23 package is universally preferred for all commercial-industrial surface mount applications and suited for low voltage applications such as DC/DC converters.

**SOT-23**



### FEATURES

- Lower Gate Charge
- Simple Drive Requirement
- Fast Switching Characteristic

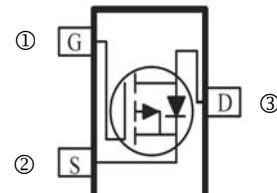
REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	2.70	3.10	G	0.01	0.18
B	2.10	2.65	H	0.5 Typ.	
C	1.20	1.40	J	0.08	0.20
D	0.89	1.17	K	0.6 REF.	
E	1.78	2.04	L	0.95 BSC.	
F	0.30	0.50			

### MARKING

3407

### PACKAGE INFORMATION

Package	MPQ	Leader Size
SOT-23	3K	7 inch



### ABSOLUTE MAXIMUM RATINGS ( $T_A=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	$V_{DS}$	-30	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	V
Continuous Drain Current <sup>1</sup>	$I_D$	-4.1	A
Pulsed Drain Current <sup>3</sup>	$I_{DM}$	-10	A
Continuous Source Current (Diode Conduction) <sup>1</sup>	$I_S$	-3	A
Power Dissipation <sup>1</sup>	$T_A=25^\circ\text{C}$	$P_D$	1.4 W
Power Dissipation <sup>2</sup>	$T_A=70^\circ\text{C}$		0.9 W
Operating Junction & Storage Temperature	$T_J, T_{STG}$	150, -55~150	°C
Thermal Resistance Ratings			
Thermal Resistance Junction-ambient( $t \leq 10\text{s}$ ) <sup>1</sup>	$R_{\theta JA}$	89	°C / W
Thermal Resistance Junction-ambient <sup>2</sup>		357	

Notes:

1. The data tested by surface mounted on a 1 inch<sup>2</sup> FR4 board with 2OZ copper
2. Surface mounted on min. copper pad
3. Pulse width limited by Max. junction temperature.

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## ELECTRICAL CHARACTERISTICS ( $T_A=25^\circ\text{C}$ unless otherwise specified)

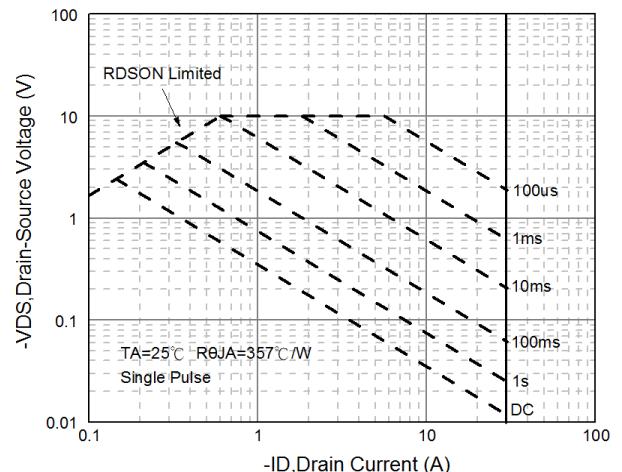
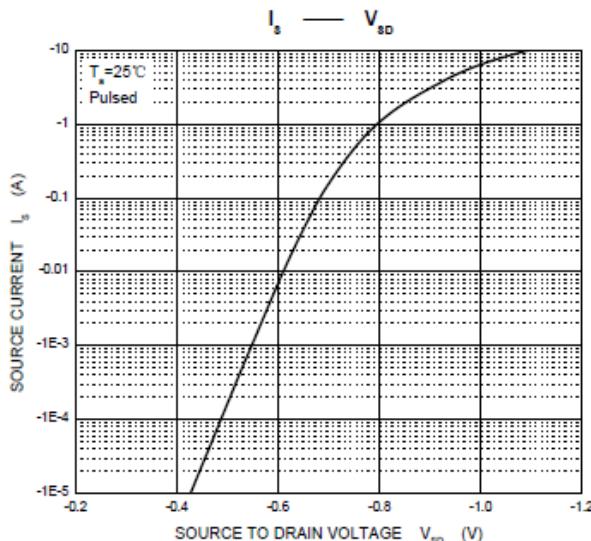
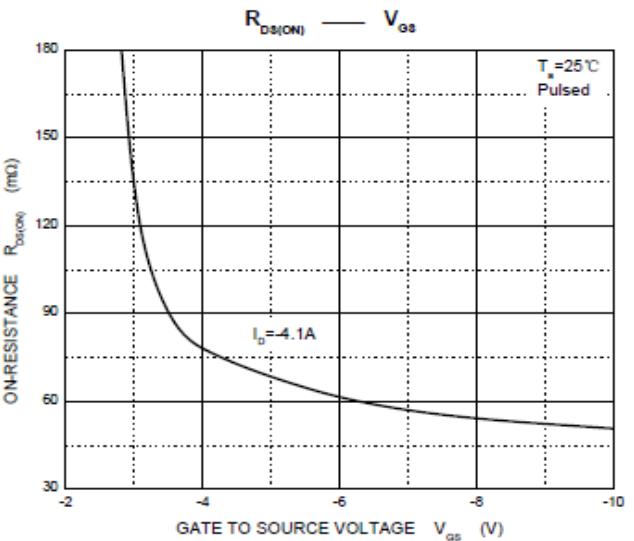
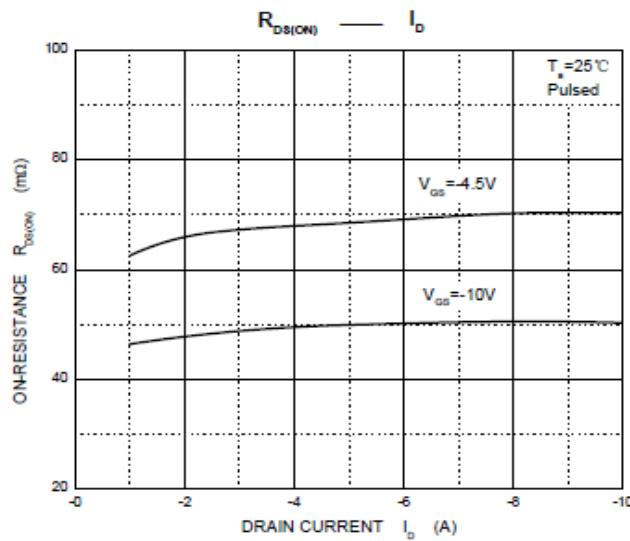
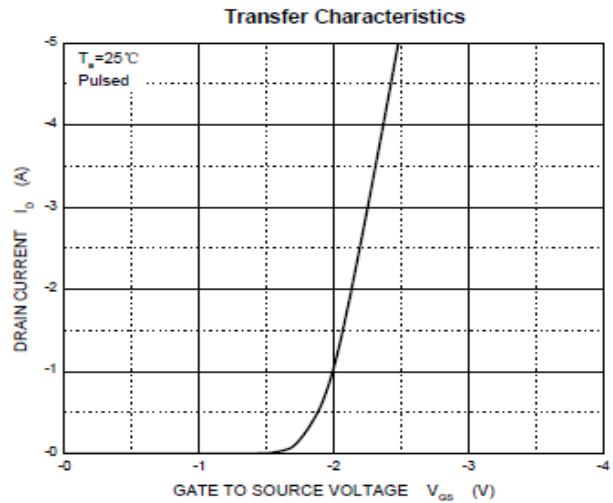
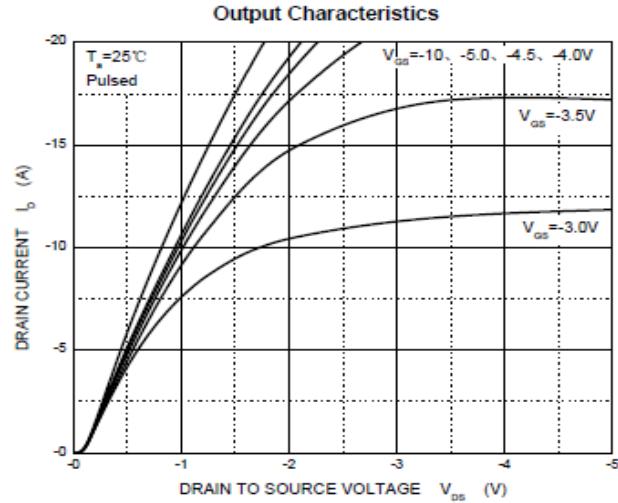
Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Condition
<b>Static</b>						
Drain-Source Breakdown Voltage	$\text{BV}_{\text{DSS}}$	-30	-	-	V	$\text{V}_{\text{GS}}=0, \text{I}_D=-250\mu\text{A}$
Gate-Threshold Voltage	$\text{V}_{\text{GS}(\text{th})}$	-1	-1.4	-3	V	$\text{V}_{\text{DS}}=\text{V}_{\text{GS}}, \text{I}_D=-250\mu\text{A}$
Gate-Source Leakage Current	$\text{I}_{\text{GSS}}$	-	-	$\pm 100$	nA	$\text{V}_{\text{GS}}= \pm 20\text{V}, \text{V}_{\text{DS}}=0$
Drain-Source Leakage Current	$\text{I}_{\text{DSS}}$	-	-	-1	$\mu\text{A}$	$\text{V}_{\text{DS}}= -24\text{V}, \text{V}_{\text{GS}}=0$
Forward Tranconductance <sup>1</sup>	$\text{g}_{\text{fs}}$	5.5	-	-	S	$\text{V}_{\text{DS}}= -5\text{V}, \text{I}_D= -4\text{A}$
Static Drain-Source On-Resistance <sup>1</sup>	$\text{R}_{\text{DS}(\text{ON})}$	-	50	60	$\text{m}\Omega$	$\text{V}_{\text{GS}}= -10\text{V}, \text{I}_D=-4.1\text{A}$
		-	68	87		$\text{V}_{\text{GS}}= -4.5\text{V}, \text{I}_D= -3\text{A}$
<b>Dynamic Parameters</b>						
Input Capacitance	$\text{C}_{\text{iss}}$	-	700	-	$\text{pF}$	$\text{V}_{\text{GS}}=0$ $\text{V}_{\text{DS}}= -15\text{V}$ $f = 1.0\text{MHz}$
Output Capacitance	$\text{C}_{\text{oss}}$	-	120	-		
Reverse Transfer Capacitance	$\text{C}_{\text{rss}}$	-	75	-		
<b>Switching Parameters</b>						
Turn-on Delay Time	$\text{T}_{\text{d}(\text{on})}$	-	8.6	-	$\text{nS}$	$\text{V}_{\text{GS}}= -10\text{V}$ $\text{V}_{\text{DS}}= -15\text{V}$ $\text{R}_{\text{GEN}}=3\Omega$ $\text{R}_{\text{L}}=3.6\Omega$
Rise Time	$\text{T}_r$	-	5	-		
Turn-off Delay Time	$\text{T}_{\text{d}(\text{off})}$	-	28.2	-		
Fall Time	$\text{T}_f$	-	13.5	-		
<b>Source-Drain Diode</b>						
Forward Voltage <sup>1</sup>	$\text{V}_{\text{SD}}$	-	-	-1	V	$\text{V}_{\text{GS}}=0, \text{I}_S= -1\text{A}$

Note:

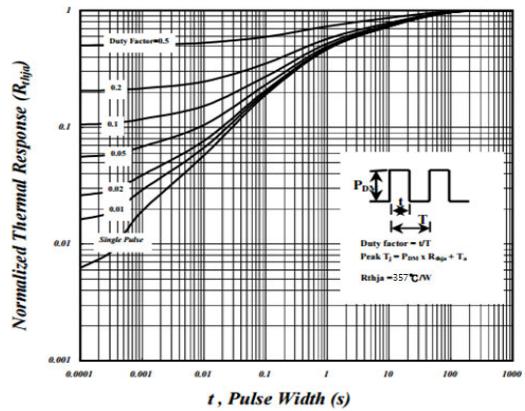
1. Pulse Test : Pulse width  $\leq 300\mu\text{s}$ , duty cycle  $\leq 2\%$ .

# YS3407

## CHARACTERISTIC CURVES



## CHARACTERISTIC CURVES



**Effective Transient Thermal Impedance**